IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In Re Application of:)
Shunpei YAMAZAKI et al)
Serial No: 09/255,605)
Filed: February 22, 1999)
Art Unit: 2629)
Examiner: Vincent E. Kovalick)
For: INFORMATION PROCESSING DEVICE)

CORRECTION OF FORM 1449

To: Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

On May 10, 2006, Applicant filed an information disclosure statement and PTO form1449 which contained a typographical error.

Specifically, under "Foreign Patent Documents" on form 1449:

- Item 1 should read: SHINOHARA, T. et al, "High-Performance Polycrystalline TFTs Using Self-Aligned Grain Boundary Control Technique," Electronics and Communications in Japan, part II: Electronics, vol. 76, no. 10, pp. 99-106, (October, 1998). (To correct the misspelling of "Boundary")

Accordingly, we are submitting a new 1449 form with this information. No new material is being added. If any fee is required in connection with this matter, please charge Deposit Account no. 50/1039.

Respectfully submitted,

Mark J. Murphy

Registration No: 34,225

Date: September 18, 2006

COOK, ALEX, McFARRON, MANZO, CUMMINGS & MEHLER, Ltd. 200 West Adams Street Suite 2850 Chicago, Illinois 60606 (312) 236-8500

Customer No: 000026568

			Atty. Docket No SEL 125		<u>Serial No.</u> 09/255,605			
LIST OF PUBLICATIONS CITED BY APPLICANT			Applicant Shunpei YAMAZAKI et al					
			<u>Filing Date</u> February 22, 199	<u>Group</u> 99 2629				
US PATENT DOCUMENTS								
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB- CLASS	FILING DATE		

FOREIGN PATENT DOCUMENTS								
	DOCUMENT NUMBER	DATE	APPLICANT	English Abstract	English Trans.	FILING DATE		
OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS (Include name of author (in CAPITAL LETTERS), title of article or item (book, magazine, journal, serial, symposium, catalog, etc.) date, pages(s), volume-issue number(s), publisher, city and/or country where published).								
1) SHINOHARA, T. et al, "High-Performance Polycrystalline Silicon TFTs Using Self-Aligned Grain Boundary Control Technique," Electronics and Communications in Japan, Part II: Electronics, vol. 76, no. 10, pp. 99-106, (October, 1993).								
EXAMINER:				DATE CONSIDER	TE CONSIDERED:			
*EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP form. Draw line through citation if not in conformance and not								

Include a copy of this form with the next communication to applicant.

considered.